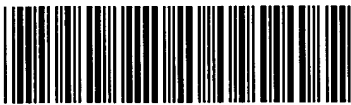


Search Notes

Application/Control No.

10/733,246

Examiner

Hai C. Pham

Applicant(s)/Patent under
Reexamination

SERIZAWA ET AL.

Art Unit

2861

SEARCHED

Class	Subclass	Date	Examiner
347	235, 241- 242, 245, 250, 263	6/11/2006	HP
	256-257		
359	196, 204	6/11/2006	HP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Text Search	6/7/2006	HP
EAST Text Search	6/10/2006	HP